

Search Notes

Application/Control No.

10/627,010

Examiner

Omar F. Fernández Rivas

Applicant(s)/Patent under
Reexamination

BODIN ET AL.

Art Unit

2129

SEARCHED

Class	Subclass	Date	Examiner
706	21,18,20 23,903, 908	10/26/2005	OFR
709	220,204	10/26/2005	OFR
709	222,245	10/26/2005	OFR
709	228,201	10/26/2005	OFR
709	223,224	10/26/2005	OFR
709	202,229	10/26/2005	OFR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East- all databases -keywords: device, metric, parameter, preference, control, vector	10/26/2005	OFR
IEEE database search -keywords: device administration, device management	10/26/2005	OFR
Class 706 subclasses: 18,20,21,903,908 -search restricted as noted in attached documents	10/26/2005	OFR
Class 709 subclasses: 201,202,,204,220,222,223,224,228, 229,245 -Search restricted as noted in attached documents	10/26/2005	OFR
Inventor name search -Bodin, William K -Burkhart, Michael J -Eisenhauer, Daniel G -Schumacher, Daniel M -Watson, Thomas J	10/26/2005	OFR